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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/802,531	HEINER ET AL.	
Examiner	Art Unit	
Qi Han	2626	

	SEARCHED		
Class	Subclass	Date	Examiner
704	277	9/30/2007	QН
704	270	9/30/2007	QH
704	9	9/30/2007	QH
704	1	9/30/2007	QH
F			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search	9/30/2007	QH
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